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APPLICATION NO.	FILING DATE	FIRST NAMED INVENTOR	ATTORNEY DOCKET NO.	CONFIRMATION NO
10/083,261	02/25/2002	Joon-Hoo Choi	8071-12 (OPP 011059US)	7814
5	7590 03/26/2004		EXAMINER	
Frank Chau, Esq. F. CHAU & ASSOCIATES, LLP			WANG, GEORGE Y	
Suite 501	330CIATES, EEI	ART UNIT	PAPER NUMBER	
1900 Hempste	-	2871		
East Meadow, NY 11554			DATE MAILED: 03/26/2004	

Please find below and/or attached an Office communication concerning this application or proceeding.

		Applic	ation No.	Applicant(s)			
Office Action Summary		10/083	3,261	CHOI ET AL.			
		Exami	ner	Art Unit			
		George	e Y. Wang	2871			
Period fo	The MAILING DATE of this commun or Reply	nication appears on	the cover sheet w	ith the correspondence add	iress		
THE - Exte after - If the - If NO - Failu Any	ORTENED STATUTORY PERIOD IN MAILING DATE OF THIS COMMUN IN INSIGHT OF THIS COMMUN IN INC. (6) MONTHS from the mailing date of this complete of the provision of period for reply specified above is less than thirty (6) period for reply is specified above, the maximum some to reply within the set or extended period for reply received by the Office later than three months and patent term adjustment. See 37 CFR 1.704(b).	IICATION. s of 37 CFR 1.136(a). In no munication. 30) days, a reply within the tatutory period will apply ar y will, by statute, cause the	o event, however, may a statutory minimum of thin and will expire SIX (6) MOI application to become A	reply be timely filed ty (30) days will be considered timely. NTHS from the mailing date of this cor BANDONED (35 U.S.C. § 133).	mmunication.		
Status							
1)[🛛	Responsive to communication(s) fil	ed on 31 Decembe	r 2003.				
2a)□	, , ,	2b)⊠ This action i					
3)							
	closed in accordance with the practice under Ex parte Quayle, 1935 C.D. 11, 453 O.G. 213.						
Disposit	ion of Claims						
5)□ 6)⊠ 7)⊠	Claim(s) <u>1-32</u> is/are pending in the 4a) Of the above claim(s) <u>3-19 and</u> Claim(s) is/are allowed. Claim(s) <u>1,2 and 6-12</u> is/are rejecte Claim(s) <u>7-8</u> is/are objected to. Claim(s) are subject to restri	<u>24-32</u> is/are withdra d.		ration.			
Applicat	on Papers				·		
10)⊠	The specification is objected to by the drawing(s) filed on 25 February Applicant may not request that any objected the country of the countr	2002 is/are: a)⊠ ection to the drawing(g the correction is rec	s) be held in abeyar quired if the drawing	nce. See 37 CFR 1.85(a). i(s) is objected to. See 37 CFI	R 1.121(d).		
Priority (	ınder 35 U.S.C. § 119						
a)i	Acknowledgment is made of a claim  All b) Some * c) None of:  1. Certified copies of the priority  2. Certified copies of the priority  3. Copies of the certified copies application from the Internationsee the attached detailed Office actions	documents have be documents have be of the priority documents Bureau (PCT F	peen received. Deen received in A Diments have been Rule 17.2(a)).	Application No received in this National S	Stage		
Attachmen	t(s)						
	e of References Cited (PTO-892)			Summary (PTO-413)			
3) 🔲 Infor	e of Draftsperson's Patent Drawing Review (I nation Disclosure Statement(s) (PTO-1449 or r No(s)/Mail Date			s)/Mail Date nformal Patent Application (PTO- 	152)		

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#### **DETAILED ACTION**

#### Election/Restrictions

1. Claims 3-5, 13-19, 21, and 24-32 were withdrawn from further consideration pursuant to 37 CFR 1.142(b), there being no allowable generic or linking claim in Response filed 11 September 2003.

2. Claims 20, 22, and 23 are now withdrawn from further consideration pursuant to 37 CFR 1.142(b), as being drawn to a nonelected Specie (2), there being no allowable generic or linking claim. Applicant timely traversed the restriction (election) requirement in Response filed December 31, 2003.

Applicant agrees that Specie (1), Claims 1-2 and 6-12 are distinct from Specie (2), Claims 20 and 22-23 as set forth by Examiner. However, Applicant argues that the examination of the two species will not present an undue burden. Examiner disagrees and asserts that examination of both species will present an undue burden. Therefore, restriction is proper and final.

#### Claim Objections

3. Claims 7 and 8 are objected to under 37 CFR 1.75(c), as being of improper dependent form for failing to further limit the subject matter of a previous claim. Claim 7 and 8 depend on Claim 6, but Claim 6 has the limitation "a-Si:C:O layer **or** a-Si:O:F layer." Thus, Claim 7, which depends only on the a-Si:C:O layer, and Claim 8, which

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only depends on the a-Si:C:O layer, are improper because there is insufficient antecedent basis for this limitation in the claim since Claim 6 does not specify which layer. Applicant is required to cancel the claim(s), or amend the claim(s) to place the claim(s) in proper dependent form.

### Claim Rejections - 35 USC § 102

4. The following is a quotation of the appropriate paragraphs of 35 U.S.C. 102 that form the basis for the rejections under this section made in this Office action:

A person shall be entitled to a patent unless -

- (b) the invention was patented or described in a printed publication in this or a foreign country or in public use or on sale in this country, more than one year prior to the date of application for patent in the United States.
- 5. Claims 1, 9, and 11-12 are rejected under 35 U.S.C. 102(b) as being anticipated by Gu et al. (U.S. Patent No. 5,920,084, hereinafter "Gu").
- 6. As to claim 1, Gu discloses a thin film transistor array substrate comprising an insulating substrate (fig. 6, ref. 9), a first signal line (fig. 6, ref. 17) formed on the insulating substrate, a first insulating layer formed on the first signal line (fig. 6, ref. 21), a second signal line formed on the first insulating layer while crossing over the first signal line (fig. 6, ref. 13, 15), a thin film transistor (TFT) connected to the first and second signal lines (fig. 6, ref. 23), a second insulating layer formed on the TFT with a first contact hole (fig. 27) exposing predetermined electrode of the TFT and having a dielectric constant about 4.0 or less (abstract; col. 7, line 65 col. 8, line 18), and a first

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pixel electrode (fig. 6, ref. 3) formed on the second insulating layer while being connected to the predetermined electrode of the TFT through the first contact hole (fig. 6, ref. 35; col. 10, line 66 – col. 11, line 5).

- 7. As per claim 9, Gu discloses a TFT array substrate as recited above where the second insulating layer has a dielectric constant of about 2 to about 4 (abstract; col. 7, line 65 col. 8, line 18).
- 8. Regarding claims 11-12, Gu discloses a TFT array substrate as recited above where the pixel electrode is made of an optically transparent and electrically conductive material such as ITO (col. 8, lines 21-22).

## Claim Rejections - 35 USC § 103

- 9. The following is a quotation of 35 U.S.C. 103(a) which forms the basis for all obviousness rejections set forth in this Office action:
  - (a) A patent may not be obtained though the invention is not identically disclosed or described as set forth in section 102 of this title, if the differences between the subject matter sought to be patented and the prior art are such that the subject matter as a whole would have been obvious at the time the invention was made to a person having ordinary skill in the art to which said subject matter pertains. Patentability shall not be negatived by the manner in which the invention was made.

This application currently names joint inventors. In considering patentability of the claims under 35 U.S.C. 103(a), the examiner presumes that the subject matter of the various claims was commonly owned at the time any inventions covered therein were made absent any evidence to the contrary. Applicant is advised of the obligation under 37 CFR 1.56 to point out the inventor and invention dates of each claim that was

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not commonly owned at the time a later invention was made in order for the examiner to consider the applicability of 35 U.S.C. 103(c) and potential 35 U.S.C. 102(e), (f) or (g) prior art under 35 U.S.C. 103(a).

- 10. Claims 2 and 6-8 are rejected under 35 U.S.C. 103(a) as being unpatentable over Gu in view of Chen et al. (U.S. Patent No. 6,362,028, hereinafter "Chen").
- 11. As per claim 2, Gu discloses a TFT array substrate with a first insulating layer made of silicon nitride (col. 9, lines 58-64) and other materials with dielectric of 4 or less (col. 7, line 65 col. 8, line 18) as recited above, however, the reference fails to specifically disclose a second bottom dielectric layer.

Chen discloses a TFT substrate having a first insulating layer with a top layer (fig. 1, ref. 20) made of silicon nitride and a bottom layer (fig. 1, ref. 16) made of a low dielectric material.

It would have been obvious to one of ordinary skill in the art at the time the invention was made to have a first insulating layer with a top layer formed of silicon nitride and a second bottom layer formed of a dielectric of 4 or less since one would be motivated to reduce defects such as pin holes and to improve yield (col. 2, lines 25-28).

12. Regarding claim 6, Gu discloses a TFT array substrate (abstract) as recited above with a second insulating layer formed with an a-Si layer, however, the reference

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fails to specifically disclose a second insulating layer formed with an a-Si:C:O or a-Si:O:F layer.

It would have been obvious to one of ordinary skill in the art at the time the invention was made to have formed a second insulating layer formed with an a-Si:C:O or a-Si:O:F layer since one would be motivated to use these well known amorphous silicon materials to improve contact resistance and to reduce chemical contaminants, which ultimately shields the TFT from plasma damage and residual photoresists resulting in a TFT array substrate of improved reliability (Chen, abstract).

- 13. As to claims 7-8, Gu discloses an a-Si TFT array substrate as recited above (abstract), however, the reference fails to specifically the a-Si layer being formed by a PECVD method. Nevertheless, even though the product-by-process limitation "is formed through plasma enhanced chemical vapor deposition (PECVD)…" is recognized as limited by and defined by the process, determination of patentability is based on the product itself. The patentability of a product does not depend on its method of production. If the product in the product-by-process claim is the same as or obvious from a product of the prior art, the claim is unpatentable even though the prior art product was made by a different process. *In re Thorpe*, 227 USPQ 964, 966 (Fed. Cir. 1985). See also MPEP 2113.
- 14. Claim 10 is rejected under 35 U.S.C. 103(a) as being unpatentable over Gu in view of Sasano et al. (U.S. Patent No. 5,671,027, hereinafter "Sasano").

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Gu discloses a TFT array substrate as recited above where the first signal line is formed of alloys of Cr or Al (col. 10, lines 5-8).

However, the reference fails to specifically disclose that the first signal line includes a first and a second layer.

Sasano discloses a TFT substrate with a first signal line having a first layer (fig. 2a, ref. g1) made of Cr alloy (col. 13, lines 5-6) and a second layer (fig. 2a, ref. g2) made of Al alloy (col. 13, lines 18-19).

It would have been obvious to one of ordinary skill at the time the invention was made to have a first signal line having a first layer made of Cr alloy and a second layer made of Al alloy since one would be motivated to reduce short circuiting that leads to defects and deterioration (col. 1, lines 65-68) and to increase excellent display performance (col. 2, lines 16-18).

#### Conclusion

15. Any inquiry concerning this communication or earlier communications from the examiner should be directed to George Y. Wang whose telephone number is 571-272-2304. The examiner can normally be reached on M-F, 8 am - 4:30 pm.

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Robert H. Kim can be reached on 571-272-2293. The fax phone number for the organization where this application or proceeding is assigned is 703-872-9306.

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Information regarding the status of an application may be obtained from the Patent Application Information Retrieval (PAIR) system. Status information for published applications may be obtained from either Private PAIR or Public PAIR. Status information for unpublished applications is available through Private PAIR only. For more information about the PAIR system, see http://pair-direct.uspto.gov. Should you have questions on access to the Private PAIR system, contact the Electronic Business Center (EBC) at 866-217-9197 (toll-free).

gw March 10, 2004 ROBERT H. KIM SUPERVISORY PATENT EXAMENSES TECHNOLOGY CENTER 28